

OptiMOS®-P2 Power-Transistor





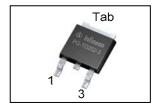
Product Summary

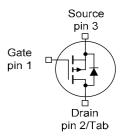
V _{DS}	-30	V
R _{DS(on)}	4.5	mΩ
I _D	-90	Α

Features

- P-channel Normal Level Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green package (RoHS compliant)
- 100% Avalanche tested

PG-TO252-3-11





Туре	Package	Marking	
IPD90P03P4-04	PG-TO252-3-11	4P0304	

Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ¹⁾	I _D	T _C =25°C, V _{GS} =-10V	-90	А
		T _C =100°C, V _{GS} =-10V ²⁾	-90	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25°C	-360	
Avalanche energy, single pulse	E _{AS}	I _D =-45A	370	mJ
Avalanche current, single pulse	I _{AS}	-	-90	А
Gate source voltage	V_{GS}	-	±20	V
Power dissipation	P_{tot}	T _C =25 °C	137	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 + 175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics ²⁾						
Thermal resistance, junction - case	R_{thJC}	-	-	-	1.1	K/W
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ³⁾	-	-	40	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, I _D = -1mA	-30	-	-	V
Gate threshold voltage	V _{GS(th)}	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = -253 \mu A$	-2.0	-3.0	-4.0	
Zero gate voltage drain current	I _{DSS}	V _{DS} =-24V, V _{GS} =0V, T _j =25°C	-	-0.05	-1	μA
		$V_{\rm DS}$ =-24V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =125°C ²⁾	-	-20	-200	
Gate-source leakage current	I _{GSS}	V _{GS} =-20V, V _{DS} =0V	-	-	-100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =-10V, I _D =-90A	-	3.6	4.5	mΩ



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	C iss		-	7900	10300	pF
Output capacitance	C oss	V _{GS} =0V, V _{DS} =-25V, f=1MHz	-	2340	3040	
Reverse transfer capacitance	C _{rss}		-	50	100	
Turn-on delay time	t _{d(on)}		-	35	-	ns
Rise time	t _r	V _{DD} =-15V, V _{GS} =-10V, I _D =-90A,	-	10	-	
Turn-off delay time	t _{d(off)}	$R_{\rm G}$ =3.5 Ω	-	70	-	
Fall time	t _f		-	20	-	
Gate Charge Characteristics ²⁾ Gate to source charge	Q _{gs}	$V_{\rm DD}$ =-24V, $I_{\rm D}$ =-90A, $V_{\rm GS}$ =0 to -10V	-	42	55	nC
Gate to drain charge	Q _{gd}		-	10	20	
Gate charge total	Qg		-	100	130	
Gate plateau voltage	V _{plateau}		-	-5.3	-	V
Reverse Diode						
Diode continous forward current ²⁾	Is	T -25°C	-	-	-90	Α
Diode pulse current ²⁾	I _{S,pulse}	− <i>T</i> _C =25°C	-	-	-360	
Diode forward voltage	V _{SD}	V _{GS} =0V, I _F =-90A, T _j =25°C	-	-	-1.3	V
Reverse recovery time ²⁾	t _{rr}	V _R =-15V, I _F =-50A,	-	50	-	ns
Reverse recovery charge ²⁾	Q _m	$di_{F}/dt = -100A/\mu s$	_	70	_	nC

 $^{^{1)}}$ Current is limited by bondwire; with an R_{thJC} = 1.1K/W the chip is able to carry -143A at 25°C.

²⁾ Defined by design. Not subject to production test.

³⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.



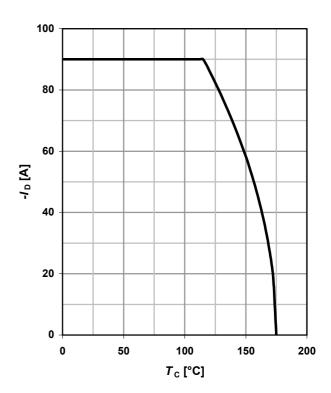
1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \leq -6V$$

160 140 120 100 P_{tot} [W] 80 60 40 20 0 0 50 100 200 150 *T*_c [°C]

2 Drain current

$$I_{\rm D} = f(T_{\rm C}); V_{\rm GS} \le -6V$$



3 Safe operating area

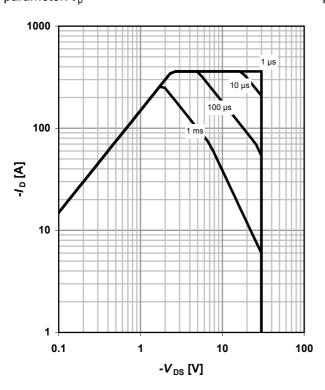
$$I_D = f(V_{DS}); T_C = 25 \,^{\circ}C; D = 0$$

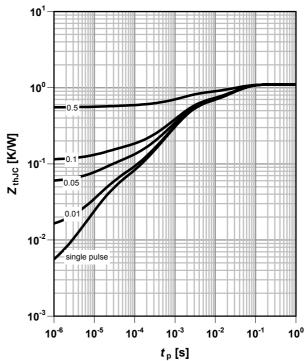
parameter: t_p

4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter: $D = t_p/T$



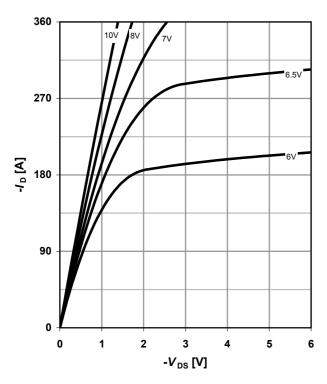




5 Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,{}^{\circ}{\rm C}$

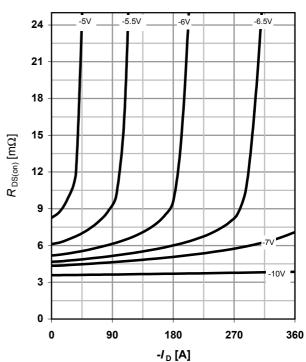
parameter: $V_{\rm GS}$



6 Typ. drain-source on-state resistance

 $R_{DS(on)} = (I_D); T_j = 25 \text{ }^{\circ}\text{C}$

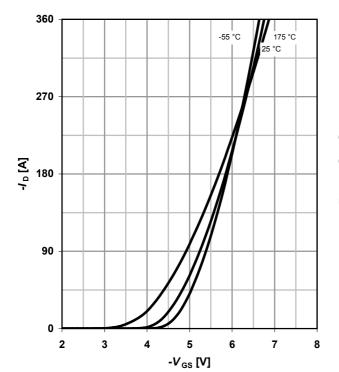
parameter: V_{GS}



7 Typ. transfer characteristics

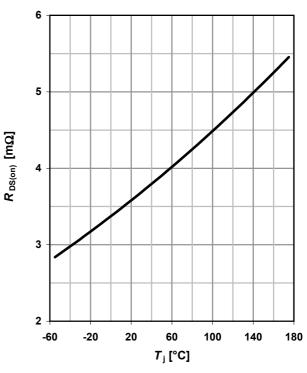
 $I_D = f(V_{GS}); V_{DS} = -6V$

parameter: T_i



8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = -90 \text{ A}; V_{GS} = -10 \text{ V}$$





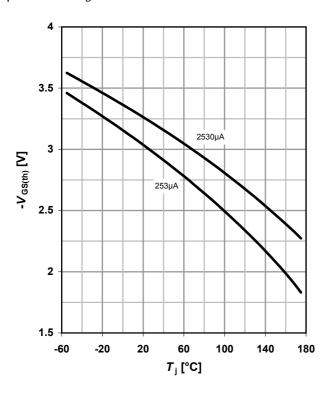
9 Typ. gate threshold voltage

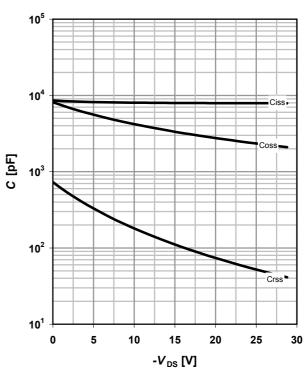
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: -I_D

10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$





11 Typical forward diode characteristicis

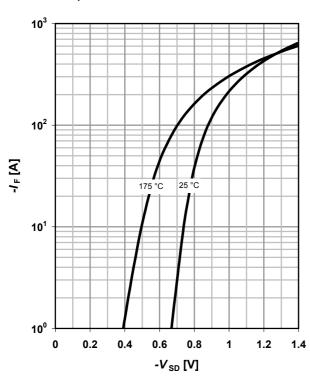
 $IF = f(V_{SD})$

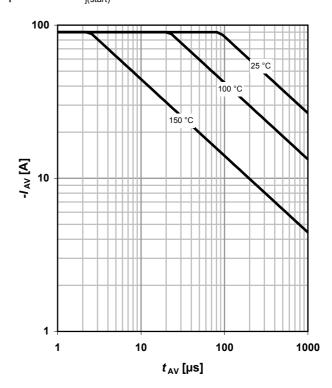
parameter: T_i

12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$

parameter: T_{j(start)}







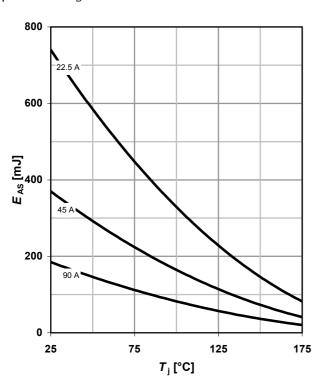
13 Avalanche energy

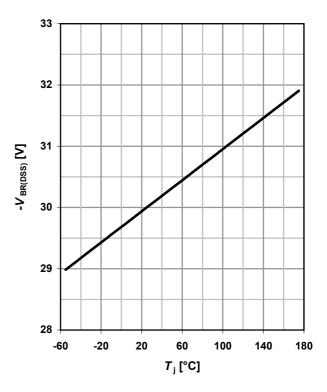
$E_{AS} = f(T_j)$

parameter: I_D

14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = -1 \text{ mA}$$



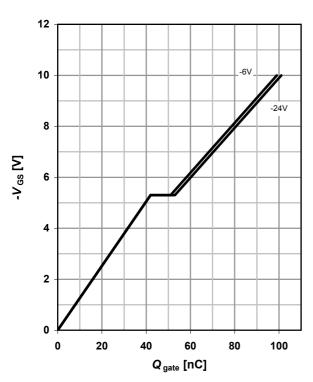


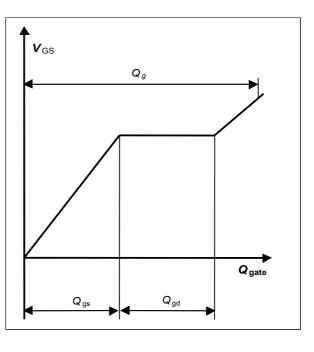
15 Typ. gate charge

 $V_{\rm GS}$ = f(Q $_{\rm gate}$); $I_{\rm D}$ = -90 A pulsed

parameter: $V_{\rm DD}$

16 Gate charge waveforms







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Revision History

Version	Date	Changes	

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Authorized Distributor

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Infineon:

IPD90P03P4-04 IPD90P03P4L-04